

 <b>INFORMATION DISCLOSURE STATEMENT</b> <small>SEARCH &amp; TRADEOFFICE</small> <small>(Use Several Sheets if necessary)</small>			ATTY DOCKET NO.	SERIAL NO.			
			62717A	10,791,408			
			APPLICANT				
			Bemius et al				
<b>FILING DATE</b> <small>March 3, 2004</small>			GROUP				
			1714				
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
SP		US 6,277,740	08/01	Goldstein	438	660	
SP		US 6,204,515 B1	03/01	Bemius et al.	257	40	
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES <input type="checkbox"/> NO <input type="checkbox"/>
SP		EP0902048 EP 902048		EP	C08K	3/24	
SP		WO02088225		WO	C08J	3/00	
<b>OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)</b>							
SP		M. Bockstaller and E. Thomas in <u>Polymer Preprints 2002</u> , 43(1), 6, pp. 6-7					
SP		M. Bockstaller, R. Kolb, and E. Thomas in <u>Adv. Mater. 2001</u> , 133, No. 23, pp. 1783-1786					
SP		T. A. Osswald and G. Menges in <u>Materials Science of Polymers for Engineers</u> , Hanser/Gardner Publications, Inc. (1995), pp. 388-389					
SP		Table 11.2, Chapter 11, D. W. Van Krevelen, <u>Properties of Polymers</u> , 3rd Ed., Elsevier, Amsterdam, 1990					
SP		Brust, M., et al., <u>J. Chem. Soc., Chem. Commun.</u> , 801 (1994)					
SP		Leff, D.V., et al., <u>J. Phys. Chem.</u> , 99, 7036 (1995)					
SP		Yee, C.K., et al., <u>Langmuir</u> , 15, 3486 (1999)					
SP		Yonezawa, T., et al., <u>Langmuir</u> , 17, 271, (2001)					
SP		Schriffin, D.J., et al., <u>MRS Bulletin</u> , 26(12), 1015 (2001)					
SP		Mossmer, S., et al., <u>Macromolecules</u> , 33, 4791 (2000)					
SP		Heilmann, A., <u>Polymer Films with Embedded Metal Nanoparticles</u> , Springer-Verlag Berlin Heidelberg New York, (2003)					
SP		Djallali, R., et al., <u>Macromolecules</u> , 35, 4248 (2002)					
SP		Cowie, J. M. G.; <u>Polymers: Chemistry and Physics of Modern Materials</u> , Intertex Books, (1973), pp. 143-144					
EXAMINER /Sandra Poulos/				DATE CONSIDERED 05/14/2006			
<small>*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to Applicant.</small>							





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			62717A		10/791,408		
			APPLICANT		Mark T. Bernius, et al.		
			FILING DATE		GROUP		
March 2, 2004		1714					
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE <i>IF APPROPRIATE</i>
SP		6,159,620	12 Dec 2000	Heath et al.	428	615	31 Mar 1998
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION <i>YES</i> <i>NO</i>
SP		EP 1 388 561 A2	11 Feb 2004	Europe	C 08 K	3/08	
SP		WO 02/087749 A	07 Nov 2002	PCT	B 01 J	13/00	
SP		DE 196 39 632 A	09 Apr 1998	Germany (English Abstract)	C 08 K	3/08	
SP		10 204350 A	04 Aug 1998	Japan (Abstract)	C 09 D	11/00	
<b>OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)</b>							
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